

74AC374 • 74ACT374

Octal D-Type Flip-Flop with 3-STATE Outputs

General Description

The AC/ACT374 is a high-speed, low-power octal D-type flip-flop featuring separate D-type inputs for each flip-flop and 3-STATE outputs for bus-oriented applications. A buffered Clock (CP) and Output Enable (OE) are common to all flip-flops.

Features

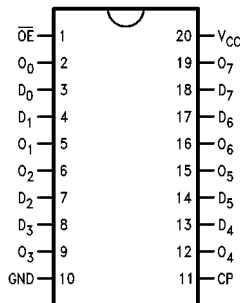
- I_{CC} and I_{OZ} reduced by 50%
- Buffered positive edge-triggered clock
- 3-STATE outputs for bus-oriented applications
- Outputs source/sink 24 mA
- See 273 for reset version
- See 377 for clock enable version
- See 373 for transparent latch version
- See 574 for broadside pinout version
- See 564 for broadside pinout version with inverted outputs
- ACT374 has TTL-compatible inputs

Ordering Code:

Order Number	Package Number	Package Description
74AC374SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74AC374SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74AC374MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC374PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
74ACT374SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74ACT374SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74ACT374MSA	MSA20	20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide
74ACT374MTC	MTC20	20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74ACT374PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Connection Diagram

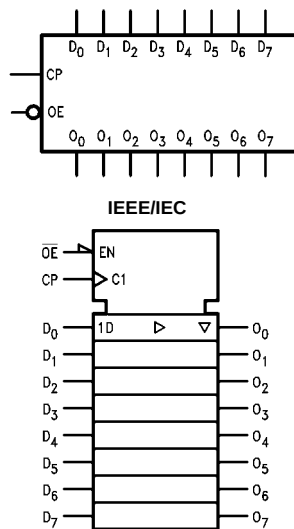


Pin Descriptions

Pin Names	Description
D_0-D_7	Data Inputs
CP	Clock Pulse Input
$\overline{OE}$	3-STATE Output Enable Input
O_0-O_7	3-STATE Outputs

FACT™ is a trademark of Fairchild Semiconductor Corporation.

Logic Symbols



Functional Description

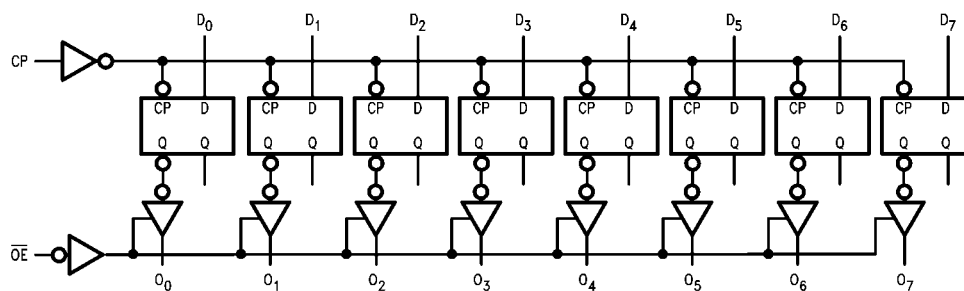
The AC/ACT374 consists of eight edge-triggered flip-flops with individual D-type inputs and 3-STATE true outputs. The buffered clock and buffered Output Enable are common to all flip-flops. The eight flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH Clock (CP) transition. With the Output Enable ($\overline{OE}$) LOW, the contents of the eight flip-flops are available at the outputs. When the $\overline{OE}$ is HIGH, the outputs go to the high impedance state. Operation of the $\overline{OE}$ input does not affect the state of the flip-flops.

Truth Table

Inputs			Outputs
D_n	CP	$\overline{OE}$	O_n
H	↗	L	H
L	↗	L	L
X	X	H	Z

H = HIGH Voltage Level
 L = LOW Voltage Level
 X = Immaterial
 Z = High Impedance
 ↗ = LOW-to-HIGH Transition

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	– 0.5V to + 7.0V
DC Input Diode Current (I_{IK})	
$V_I = -0.5V$	– 20 mA
$V_I = V_{CC} + 0.5V$	+ 20 mA
DC Input Voltage (V_I)	– 0.5V to $V_{CC} + 0.5V$
DC Output Diode Current (I_{OK})	
$V_O = -0.5V$	– 20 mA
$V_O = V_{CC} + 0.5V$	+ 20 mA
DC Output Voltage (V_O)	– 0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current (I_O)	± 50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	± 50 mA
Storage Temperature (T_{STG})	– 65°C to + 150°C
Junction Temperature (T_J) (PDIP)	140°C

Recommended Operating Conditions

Supply Voltage (V_{CC})	
AC	2.0V to 6.0V
ACT	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	–40°C to +85°C
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
AC Devices	
V_{IN} from 30% to 70% of V_{CC}	
V_{CC} @ 3.3V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate ($\Delta V/\Delta t$)	
ACT Devices	
V_{IN} from 0.8V to 2.0V	
V_{CC} @ 4.5V, 5.5V	125 mV/ns

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics for AC

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = −40°C to +85°C		Units	Conditions	
			Typ	Guaranteed Limits					
V _{IH}	Minimum HIGH Level Input Voltage	3.0	1.5	2.1	2.1		V	V _{OUT} = 0.1V or V _{CC} − 0.1V	
		4.5	2.25	3.15	3.15				
		5.5	2.75	3.85	3.85				
V _{IL}	Maximum LOW Level Input Voltage	3.0	1.5	0.9	0.9		V	V _{OUT} = 0.1V or V _{CC} − 0.1V	
		4.5	2.25	1.35	1.35				
		5.5	2.75	1.65	1.65				
V _{OH}	Minimum HIGH Level Output Voltage	3.0	2.99	2.9	2.9		V	I _{OUT} = − 50 μA	
		4.5	4.49	4.4	4.4				
		5.5	5.49	5.4	5.4				
			3.0		2.56	2.46		V	V _{IN} = V _{IL} or V _{IH} I _{OH} = − 12 mA I _{OH} = − 24 mA I _{OH} = − 24 mA (Note 2)
			4.5		3.86	3.76			
			5.5		4.86	4.76			
V _{OL}	Maximum LOW Level Output Voltage	3.0	0.002	0.1	0.1		V	I _{OUT} = 50 μA	
		4.5	0.001	0.1	0.1				
		5.5	0.001	0.1	0.1				
			3.0		0.36	0.44		V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 12 mA I _{OL} = 24 mA I _{OL} = 24 mA (Note 2)
			4.5		0.36	0.44			
			5.5		0.36	0.44			
I _{IN} (Note 4)	Maximum Input Leakage Current	5.5		±0.1	±1.0		μA	V _I = V _{CC} , GND	
I _{OZ}	Maximum 3-STATE Current	5.5		±0.25	±2.5		μA	V _I (OE) = V _{IL} , V _{IH} V _I = V _{CC} , GND V _O = V _{CC} , GND	
I _{OLD}	Minimum Dynamic	5.5			75		mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 3)	5.5			−75		mA	V _{OHD} = 3.85V Min	
I _{CC} (Note 4)	Maximum Quiescent Supply Current	5.5		4.0	40.0		μA	V _{IN} = V _{CC} or GND	

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: Maximum test duration 2.0 ms, one output loaded at a time.

Note 4: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = -40°C to +85°C		Units	Conditions
			Typ	Guaranteed Limits				
V _{IH}	Minimum HIGH Level Input Voltage	4.5	1.5	2.0	2.0	V	V _{OUT} = 0.1V or V _{CC} - 0.1V	
		5.5	1.5	2.0	2.0			
V _{IL}	Maximum LOW Level Input Voltage	4.5	1.5	0.8	0.8	V	V _{OUT} = 0.1V or V _{CC} - 0.1V	
		5.5	1.5	0.8	0.8			
V _{OH}	Minimum HIGH Level Output Voltage	4.5	4.49	4.4	4.4	V	I _{OUT} = - 50 μA	
		5.5						
		4.5		3.86	3.76	V	V _{IN} = V _{IL} or V _{IH} I _{OH} = - 24 mA I _{OH} - 24 mA (Note 5)	
		5.5		4.86	4.76			
V _{OL}	Maximum LOW Level Output Voltage	4.5	0.001	0.1	0.1	V	I _{OUT} = 50 μA	
		5.5	0.001	0.1	0.1			
		4.5		0.36	0.44	V	V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA (Note 5)	
		5.5		0.36	0.44			
I _{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	μA	V _I = V _{CC} , GND	
I _{OZ}	Maximum 3-STATE Current	5.5		±0.25	±2.5	μA	V _I = V _{IL} , V _{IH} V _O = V _{CC} , GND	
I _{CCT}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	V _I = V _{CC} - 2.1V	
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 6)	5.5			- 75	mA	V _{OHD} = 3.85V Min	
I _{CC}	Maximum Quiescent Supply Current	5.5		4.0	40.0	μA	V _{IN} = V _{CC} or GND	

Note 5: All outputs loaded; thresholds on input associated with output under test.

Note 6: Maximum test duration 2.0 ms, one output loaded at a time.

AC Electrical Characteristics

Symbol	Parameter	V _{CC} (V) (Note 7)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	3.3 5.0	60 100	110 155		60 100		MHz
t _{PLH}	Propagation Delay CP to O _n	3.3 5.0	3.0 2.5	11.0 8.0	13.5 9.5	1.5 1.5	15.5 10.5	ns
t _{PHL}	Propagation Delay CP to O _n	3.3 5.0	2.5 2.0	10.0 7.0	12.5 9.0	2.0 1.5	14.0 10.0	ns
t _{PZH}	Output Enable Time	3.3 5.0	3.0 2.0	9.5 7.0	11.5 8.5	1.5 1.0	13.0 9.5	ns
t _{PZL}	Output Enable Time	3.3 5.0	2.5 2.0	9.0 6.5	11.5 8.5	1.5 1.0	13.0 9.5	ns
t _{PHZ}	Output Disable Time	3.3 5.0	3.0 2.0	10.5 8.0	12.5 11.0	2.0 2.0	14.5 12.5	ns
t _{PLZ}	Output Disable Time	3.3 5.0	2.0 1.5	8.0 6.5	11.5 8.5	1.0 1.0	12.5 10.0	ns

Note 7: Voltage Range 3.3 is 3.3V ± 0.3V
Voltage Range 5.0 is 5.0V ± 0.5V

AC Operating Requirements

Symbol	Parameter	V _{CC} (V) (Note 8)	T _A = +25°C C _L = 50 pF		T _A = −40°C to +85°C C _L = 50 pF		Units
			Typ	Guaranteed Minimum			
t _S	Setup Time, HIGH or LOW	3.3	2.0	5.5	6.0	ns	
	D _n to CP	5.0	1.0	4.0	4.5		
t _H	Hold Time, HIGH or LOW	3.3	−1.0	1.0	1.0	ns	
	D _n to CP	5.0	0	1.5	1.5		
t _W	CP Pulse Width,	3.3	4.0	5.5	6.0	ns	
	HIGH or LOW	5.0	2.5	4.0	4.5		

Note 8: Voltage Range 3.3 is 3.3V ± 0.3V
Voltage Range 5.0 is 5.0V ± 0.5V

AC Electrical Characteristics

Symbol	Parameter	V _{CC} (V) (Note 9)	T _A = +25°C C _L = 50 pF			T _A = −40°C to +85°C C _L = 50 pF		Units
			Min	Typ	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	5.0	100	160		90		MHz
t _{PLH}	Propagation Delay CP to O _n	5.0	2.0	8.5	10.0	2.0	11.5	ns
t _{PHL}	Propagation Delay CP to O _n	5.0	2.0	8.0	9.5	1.5	11.0	ns
t _{PZH}	Output Enable Time	5.0	2.0	8.0	9.5	1.5	10.5	ns
t _{PZL}	Output Enable Time	5.0	1.5	8.0	9.0	1.5	10.5	ns
t _{PHZ}	Output Disable Time	5.0	1.5	8.5	11.5	1.0	12.5	ns
t _{PLZ}	Output Disable Time	5.0	1.5	7.0	8.5	1.0	10.0	ns

Note 9: Voltage Range 5.0 is 5.0V ± 0.5V

AC Operating Requirements

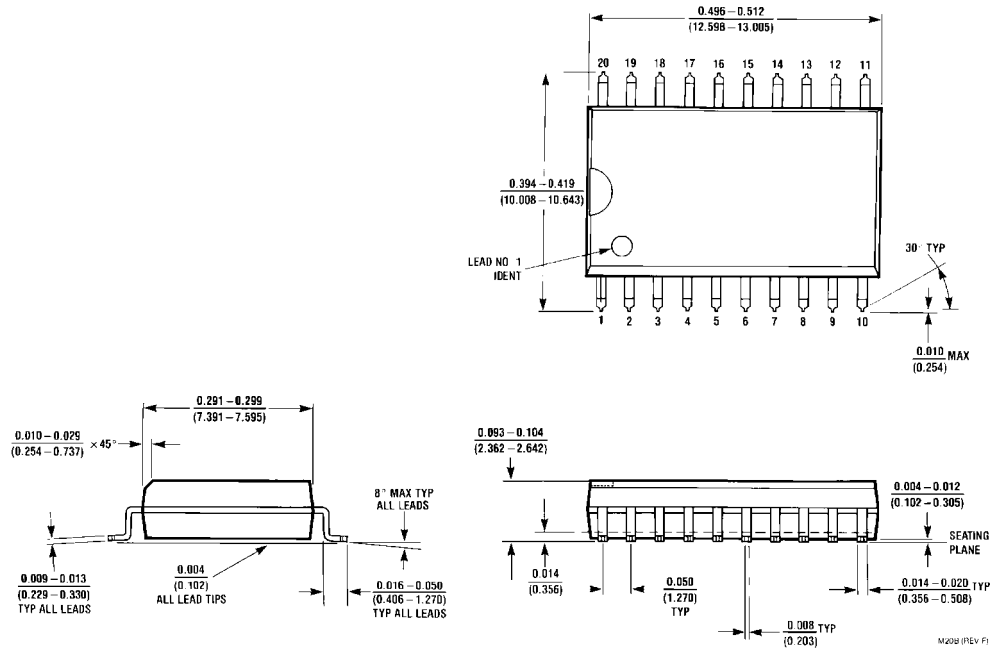
Symbol	Parameter	V _{CC} (V) (Note 10)	T _A = +25°C C _L = 50 pF		T _A = −40°C to +85°C C _L = 50 pF		Units
			Typ	Guaranteed Minimum			
t _S	Setup Time, HIGH or LOW	5.0	1.0	5.5	5.5	ns	
t _H	Hold Time, HIGH or LOW	5.0	0	1.5	1.5		
t _W	CP Pulse Width,	5.0	2.5	5.0	5.0	ns	
	HIGH or LOW						

Note 10: Voltage Range 5.0 is 5.0V ± 0.5V

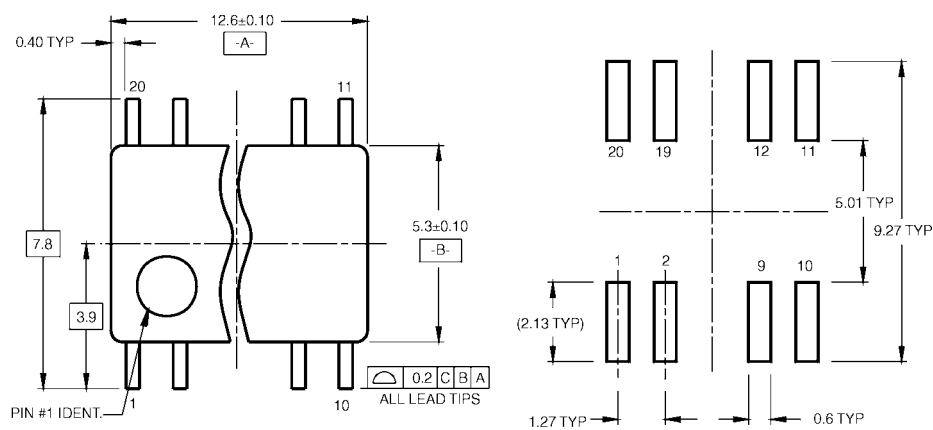
Capacitance

Symbol	Parameter	Typ	Units	Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = OPEN

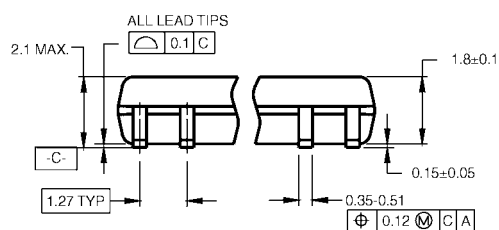
Physical Dimensions inches (millimeters) unless otherwise noted



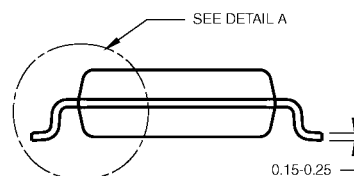
20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide Body
Package Number M20B

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)


LAND PATTERN RECOMMENDATION



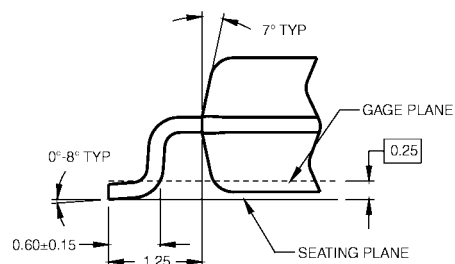
DIMENSIONS ARE IN MILLIMETERS



NOTES:

- CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
- DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

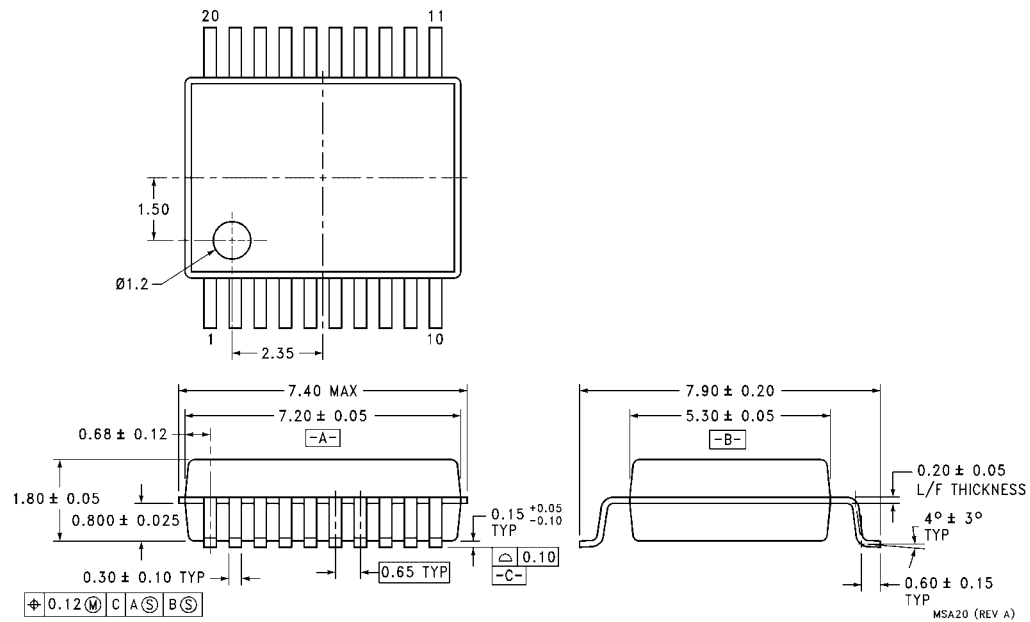
M20DRevB1



DETAIL A

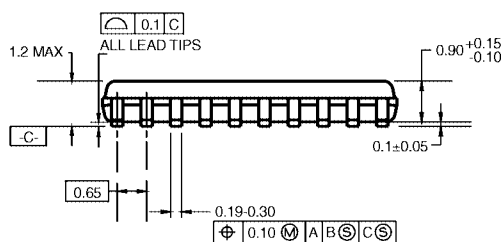
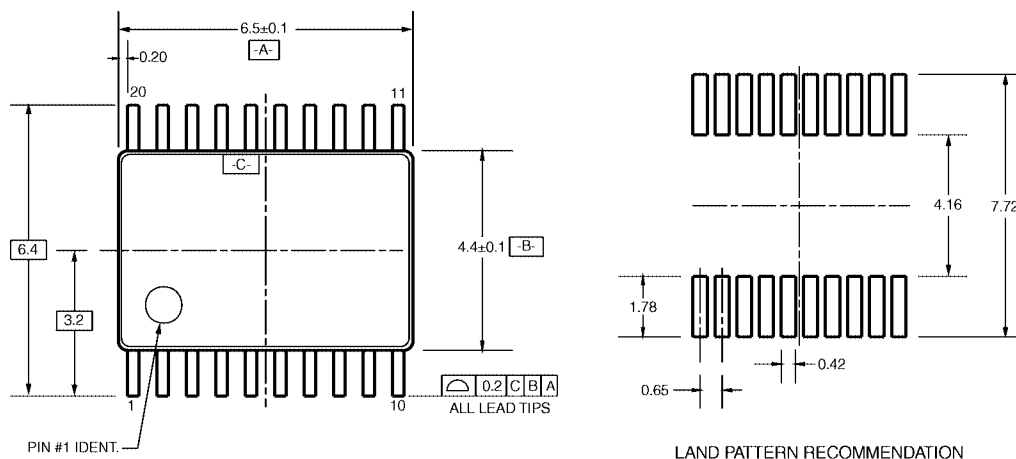
20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
Package Number M20D

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide
Package Number MSA20

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

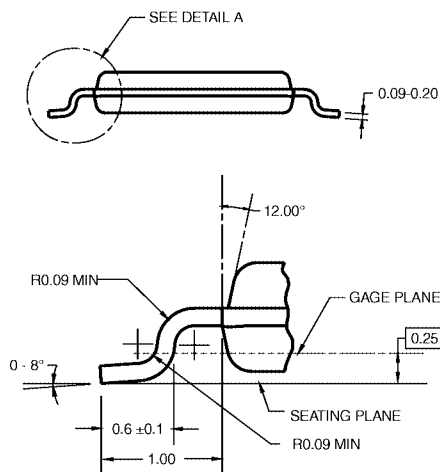


DIMENSIONS ARE IN MILLIMETERS

NOTES:

- CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AC, REF NOTE 6, DATE 7/93.
- DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTC20RevD1

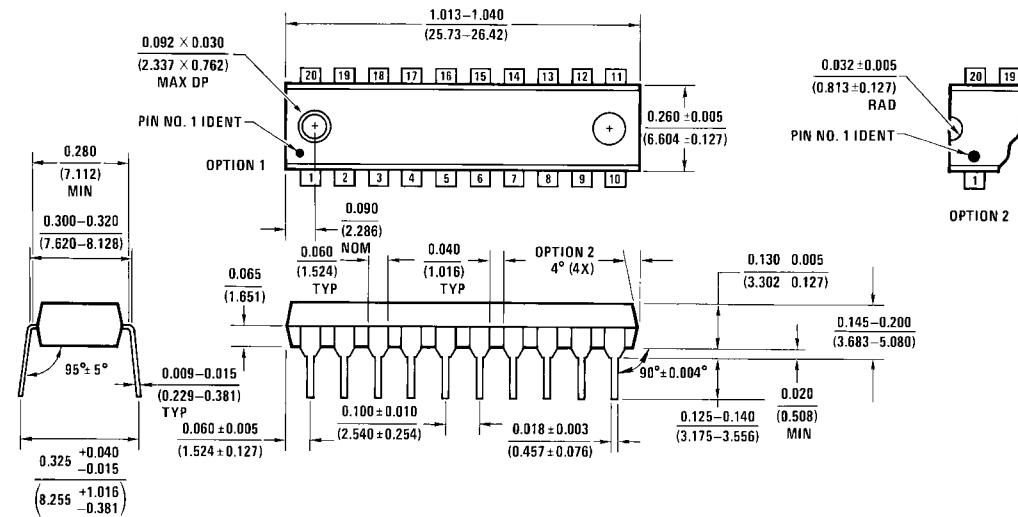


DETAIL A

**20-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
Package Number MTC20**

Physical Dimensions

inches (millimeters) unless otherwise noted (Continued)



20-Lead Plastic Dual-in-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N20A

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com